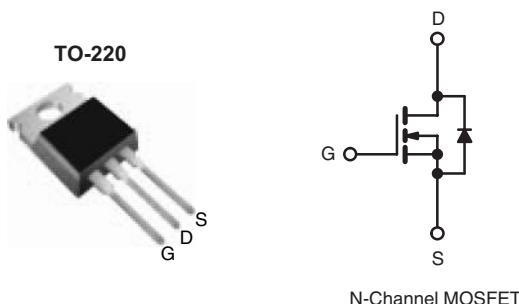


# Power MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	500
R <sub>D(on)</sub> (Ω)	V <sub>GS</sub> = 10 V      0.52
Q <sub>g</sub> (Max.) (nC)	52
Q <sub>gs</sub> (nC)	13
Q <sub>gd</sub> (nC)	18
Configuration	Single



## FEATURES

- Low Gate Charge Q<sub>g</sub> Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and current
- Lead (Pb)-free Available



## APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

## APPLICABLE OFF LINE SMPS TOPOLOGIES

- Two Transistor Forward
- Half and Full Bridge
- Power Factor Correction Boost

## ORDERING INFORMATION

Package	TO-220
Lead (Pb)-free	IRFB11N50APbF SiHFB11N50A-E3
SnPb	IRFB11N50A SiHFB11N50A

## ABSOLUTE MAXIMUM RATINGS T<sub>C</sub> = 25 °C, unless otherwise noted

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V <sub>DS</sub>	500	V
Gate-Source Voltage	V <sub>GS</sub>	± 30	
Continuous Drain Current	I <sub>D</sub>	11	A
		7.0	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	44	
Linear Derating Factor		1.3	W/°C
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	275	mJ
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	11	A
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	17	mJ
Maximum Power Dissipation	P <sub>D</sub>	170	W
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	6.9	V/ns
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s	300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw	10	lbf · in
		1.1	N · m

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Starting T<sub>J</sub> = 25 °C, L = 4.5 mH, R<sub>G</sub> = 25 Ω, I<sub>AS</sub> = 11 A (see fig. 12).

c. I<sub>SD</sub> ≤ 11 A, dI/dt ≤ 140 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE**

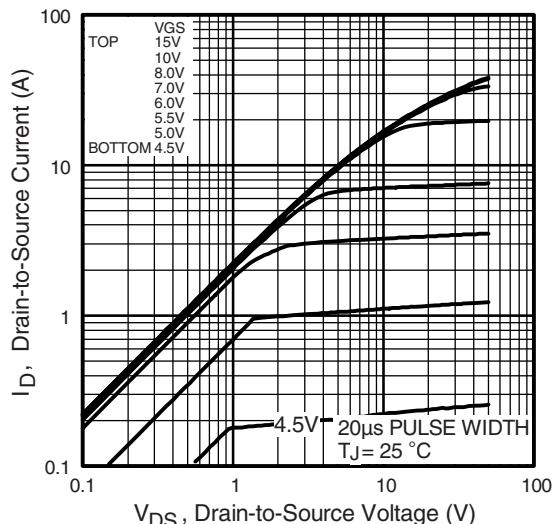
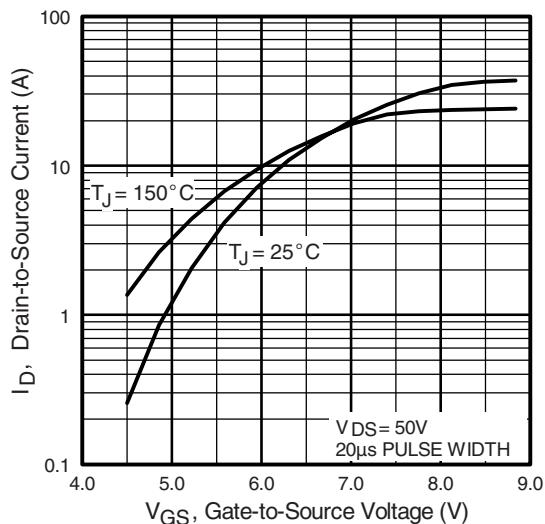
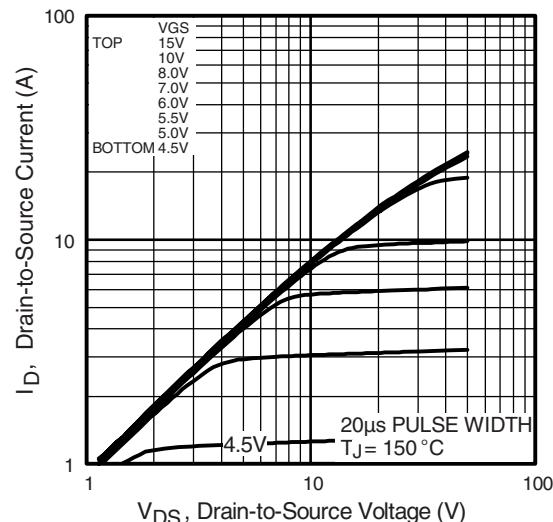
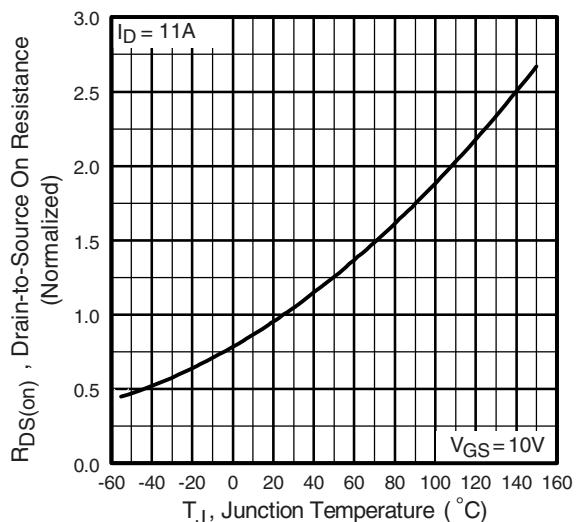
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	62	$^{\circ}\text{C}/\text{W}$
Case-to-Sink, Flat, Greased Surface	$R_{thCS}$	0.50	-	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.75	

**SPECIFICATIONS**  $T_J = 25 \text{ }^{\circ}\text{C}$ , unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$		500	-	-	V
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$		2.0	-	4.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 30 \text{ V}$		-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 500 \text{ V}$ , $V_{GS} = 0 \text{ V}$		-	-	25	$\mu\text{A}$
		$V_{DS} = 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 150 \text{ }^{\circ}\text{C}$		-	-	250	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 6.6 \text{ A}^b$	-	-	0.52	$\Omega$
Forward Transconductance	$g_{fs}$	$V_{DS} = 50 \text{ V}$ , $I_D = 6.6 \text{ A}$		6.1	-	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5		-	1423	-	pF
Output Capacitance	$C_{oss}$			-	208	-	
Reverse Transfer Capacitance	$C_{rss}$			-	8.1	-	
Output Capacitance	$C_{oss}$	$V_{GS} = 0 \text{ V}$	$V_{DS} = 1.0 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	2000	-	nC
			$V_{DS} = 400 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	55	-	
			$V_{DS} = 0 \text{ V}$ to $400 \text{ V}$	-	97	-	
Total Gate Charge	$Q_g$	$V_{GS} = 10 \text{ V}$	$I_D = 11 \text{ A}$ , $V_{DS} = 400 \text{ V}$ see fig. 6 and 13 <sup>b</sup>	-	-	52	ns
Gate-Source Charge	$Q_{gs}$			-	-	13	
Gate-Drain Charge	$Q_{gd}$			-	-	18	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 250 \text{ V}$ , $I_D = 11 \text{ A}$ $R_G = 9.1 \Omega$ , $R_D = 22 \Omega$ , see fig. 10 <sup>b</sup>		-	14	-	ns
Rise Time	$t_r$			-	35	-	
Turn-Off Delay Time	$t_{d(off)}$			-	32	-	
Fall Time	$t_f$			-	28	-	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode		-	-	11	A
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$			-	-	44	
Body Diode Voltage	$V_{SD}$	$T_J = 25 \text{ }^{\circ}\text{C}$ , $I_S = 11 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$		-	-	1.5	V
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25 \text{ }^{\circ}\text{C}$ , $I_F = 11 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	510	770	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	3.4	5.1	$\mu\text{C}$
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2 \%$ .
- c.  $C_{oss}$  effective is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80 %  $V_{DS}$ .

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

**Fig. 1 - Typical Output Characteristics**

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics**

**Fig. 4 - Normalized On-Resistance vs. Temperature**

# IRFB11N50A, SiHFB11N50A

Vishay Siliconix

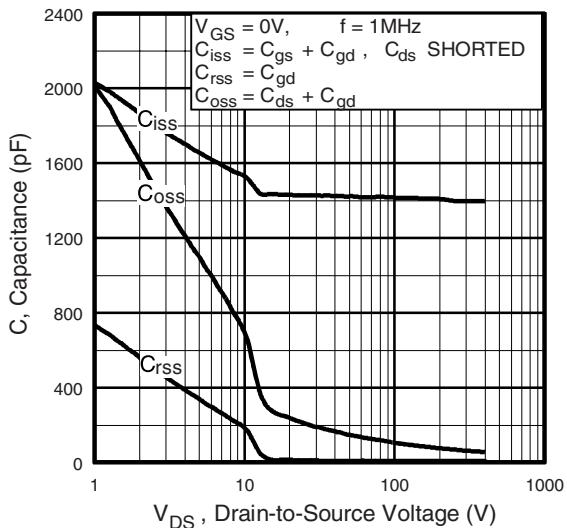


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

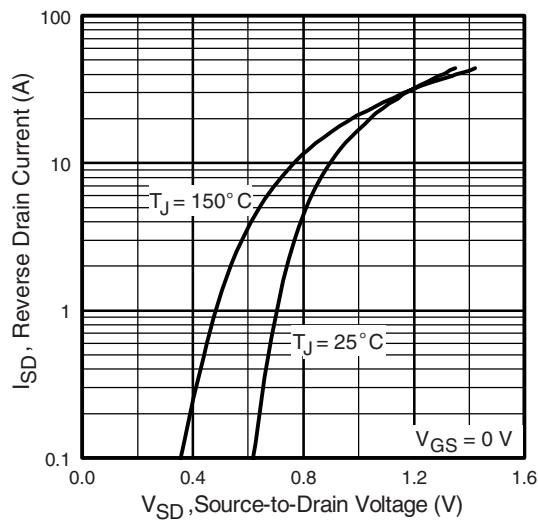


Fig. 7 - Typical Source-Drain Diode Forward Voltage

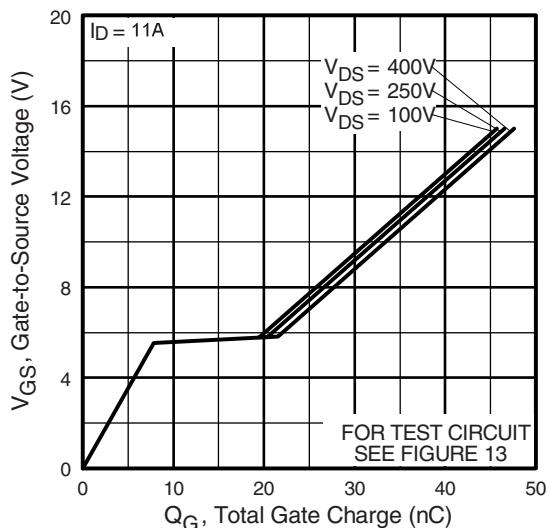


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

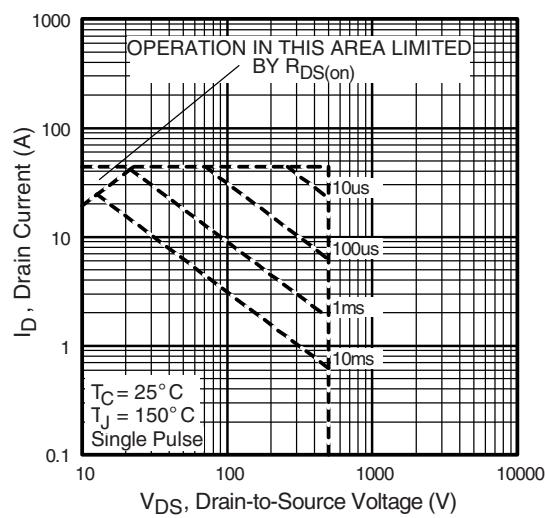


Fig. 8 - Maximum Safe Operating Area

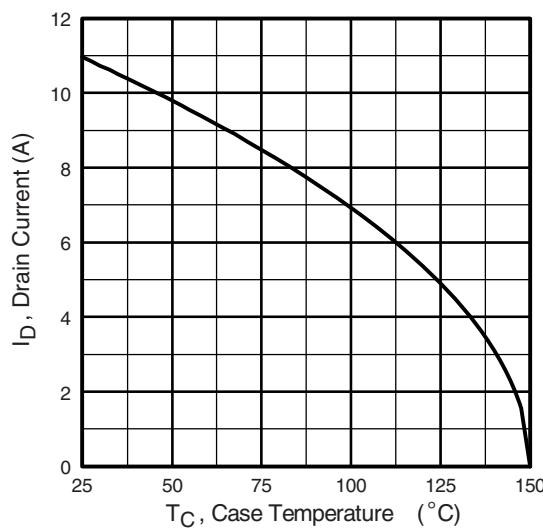


Fig. 9 - Maximum Drain Current vs. Case Temperature

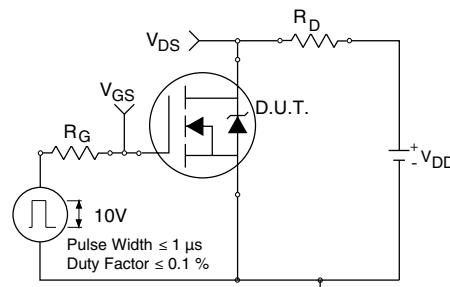


Fig. 10a - Switching Time Test Circuit

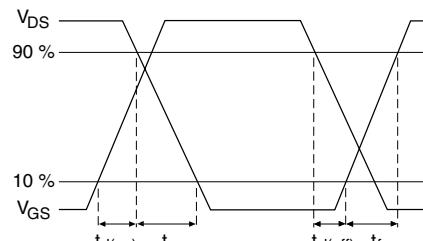


Fig. 10b - Switching Time Waveforms

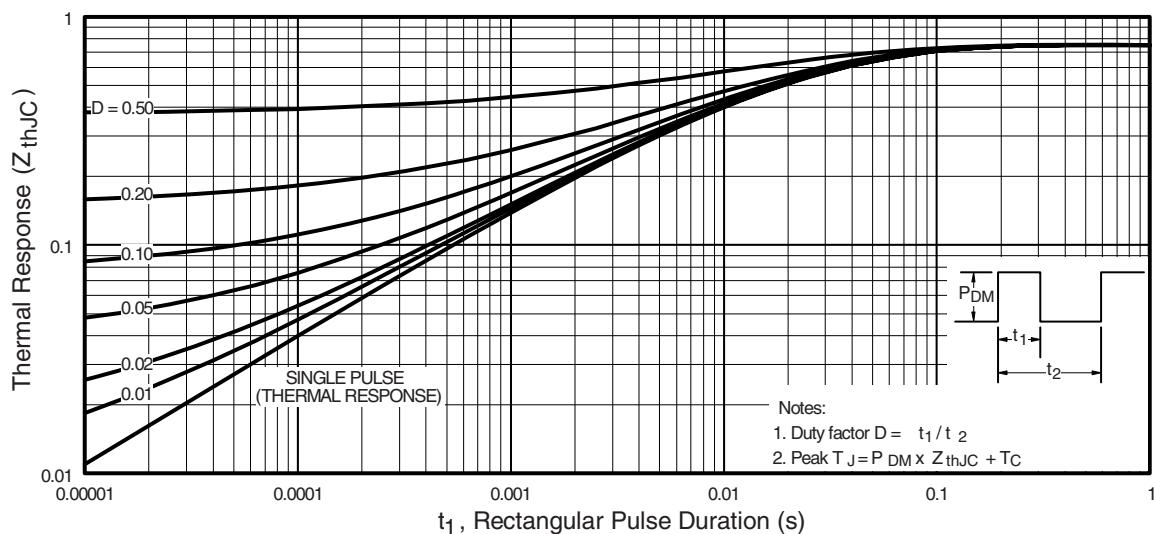


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

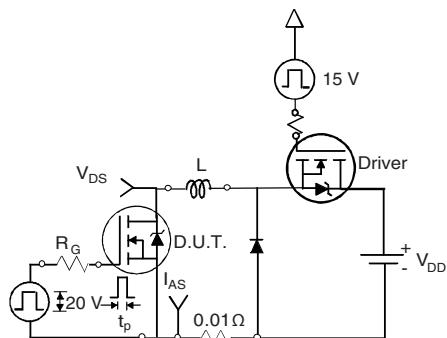


Fig. 12a - Unclamped Inductive Test Circuit

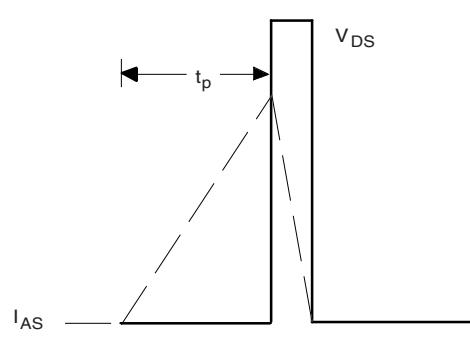


Fig. 12b - Unclamped Inductive Waveforms

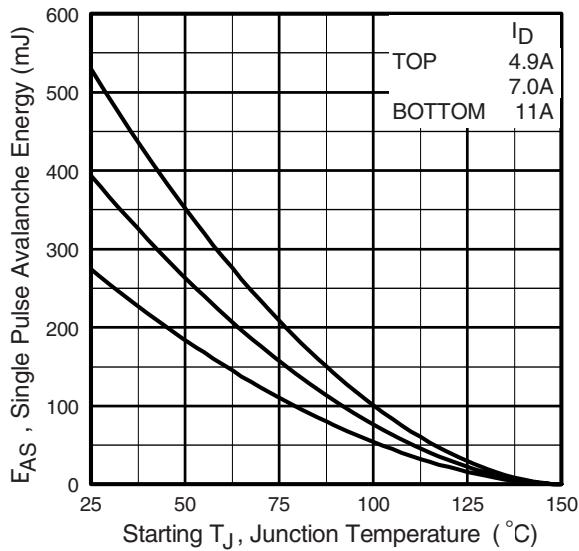


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

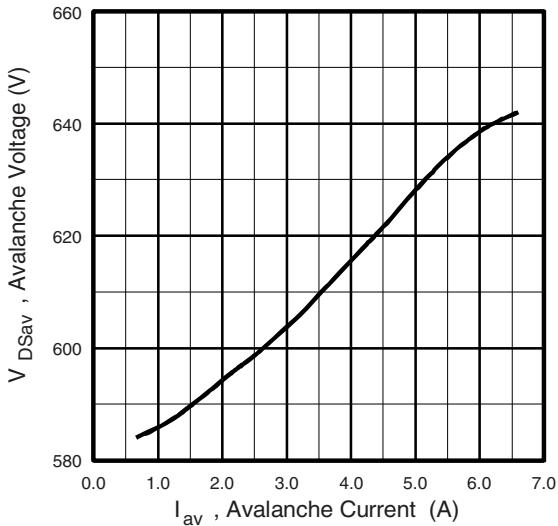


Fig. 12d - Typical Drain-to-Source Voltage vs. Avalanche Current

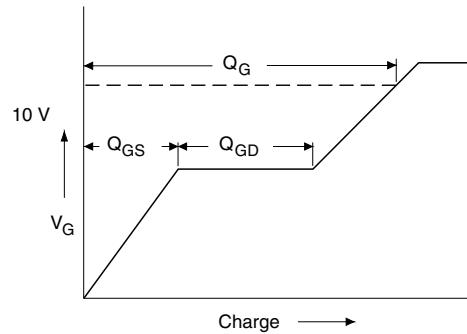


Fig. 13a - Basic Gate Charge Waveform

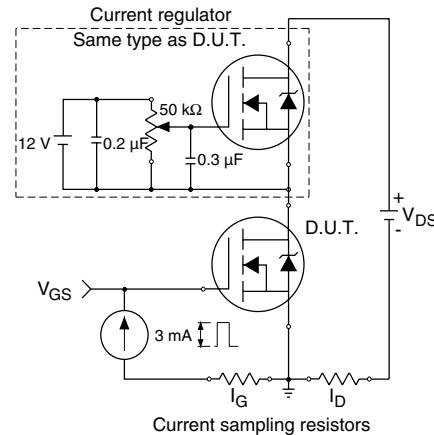
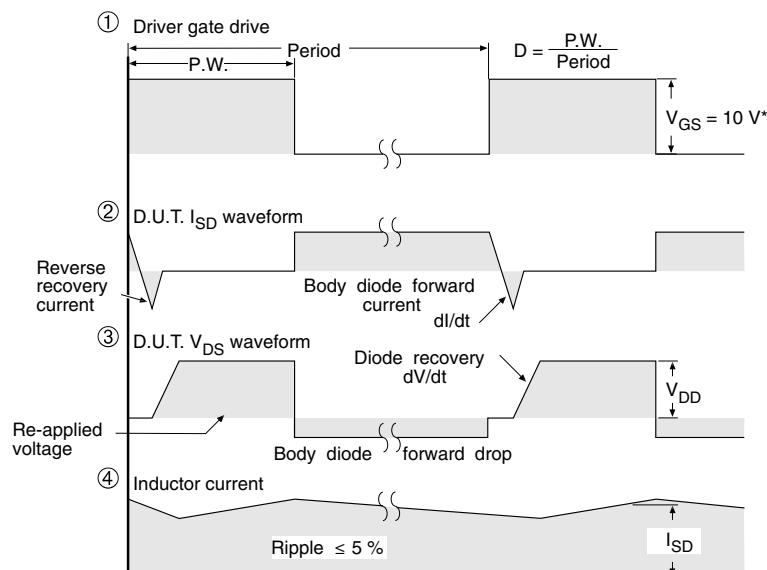
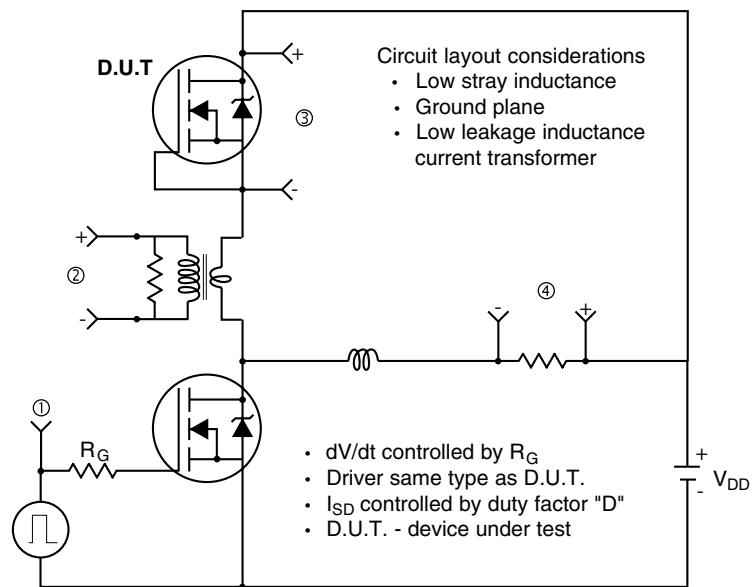


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = 5$  V for logic level devices

**Fig. 14 - For N-Channel**

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